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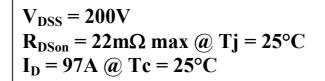


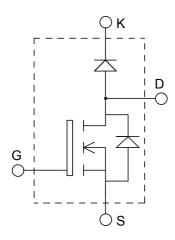






ISOTOP® Boost chopper MOSFET Power Module





Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction
- Brake switch

Features

- Power MOS V® MOSFETs
 - Low R_{DSon}
 - Low input and Miller capacitance
 - Low gate charge
 - Fast intrinsic diode
 - Avalanche energy rated
 - Very rugged
- ISOTOP® Package (SOT-227)
- Very low stray inductance
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Very rugged
- Low profile
- RoHS Compliant



Absolute maximum ratings

| Symbol | Parameter | | | Max ratings | Unit |
|--------------|---|----------------|--------------------|-------------|------|
| $V_{ m DSS}$ | Drain - Source Breakdown Voltage | | | 200 | V |
| Ţ | Continuous Drain Current $T_c = 25^{\circ}\text{C}$ | | 97 | | |
| I_{D} | Continuous Drain Current | | $T_c = 80$ °C | 72 | A |
| I_{DM} | Pulsed Drain current | 388 | | | |
| V_{GS} | Gate - Source Voltage | | | ±30 | V |
| R_{DSon} | Drain - Source ON Resistance | 22 | $m\Omega$ | | |
| P_{D} | Maximum Power Dissipation $T_c = 25^{\circ}C$ | | | 450 | W |
| I_{AR} | Avalanche current (repetitive and non repetitive) | | | 97 | A |
| E_{AR} | Repetitive Avalanche Energy | | | 50 | mJ |
| E_{AS} | Single Pulse Avalanche Energy | | | 2500 | 1113 |
| IF_{AV} | Maximum Average Forward Current | Duty cycle=0.5 | $Tc = 90^{\circ}C$ | 30 | A |
| IF_{RMS} | RMS Forward Current (Square wave, 5 | 50% duty) | · | 47 | A |

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



All ratings @ $T_j = 25$ °C unless otherwise specified

Electrical Characteristics

| Symbol | Characteristic | Test Conditions | | Min | Typ | Max | Unit |
|---------------------|---------------------------------|---|---------|-----|-----|------|------|
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{GS} = 0V, V_{DS} = 200V$ T_j | = 25°C | | | 25 | μА |
| | Zero Gate Voltage Drain Current | $V_{GS} = 0V, V_{DS} = 160V$ T_j | = 125°C | | | 250 | |
| R _{DS(on)} | Drain – Source on Resistance | $V_{GS} = 10V, I_D = 48.5A$ | | | | 22 | mΩ |
| V _{GS(th)} | Gate Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 2.5 \text{mA}$ | | 2 | | 4 | V |
| I_{GSS} | Gate – Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | | ±100 | nA |

Dynamic Characteristics

| • | Characteristic | Test Conditions | Min | Тур | Max | Unit |
|------------------|------------------------------|---|-----|------|-----|------|
| C_{iss} | Input Capacitance | $V_{GS} = 0V$ | | 8500 | | |
| C_{oss} | Output Capacitance | $V_{DS} = 25V$ | | 1950 | | pF |
| C_{rss} | Reverse Transfer Capacitance | f = 1MHz | | 560 | | |
| Q_{g} | Total gate Charge | $V_{GS} = 10V$ | | 290 | | |
| Q_{gs} | Gate – Source Charge | $V_{Bus} = 100V$ $I_D = 97A @ T_J = 25^{\circ}C$ | | 66 | | nC |
| Q_{gd} | Gate – Drain Charge | | | 120 | | |
| $T_{d(on)}$ | Turn-on Delay Time | $V_{GS} = 15V$ $V_{Bus} = 100V$ $I_D = 97A @ T_J = 25°C$ $R_G = 0.6\Omega$ | | 16 | | |
| $T_{\rm r}$ | Rise Time | | | 25 | | ns |
| $T_{d(off)}$ | Turn-off Delay Time | | | 48 | | |
| T_{f} | Fall Time | | | 8 | | |

Chopper diode ratings and characteristics

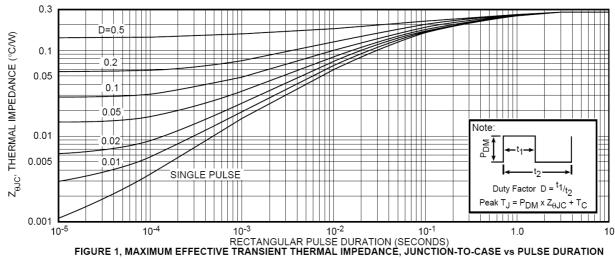
| Symbol | Characteristic | Test Conditions | | Min | Typ | Max | Unit |
|-------------------|------------------------------------|--|------------------------|-----|-----|------|-----------|
| V_{F} | Diode Forward Voltage | $I_F = 30A$ | | | 1.1 | 1.15 | |
| | | $I_F = 60A$ | | | 1.4 | | V |
| | | $I_F = 30A$ | $T_i = 125$ °C | | 0.9 | | |
| I_{RM} | Maximum Reverse Leakage Current | $V_R = 200V$ | $T_i = 25$ °C | | | 250 | μA |
| 1RM | Waximum Reverse Leakage Current | $V_R = 200V$ | $T_{i} = 125^{\circ}C$ | | | 500 | μΑ |
| C_{T} | Junction Capacitance | $V_R = 200V$ | | | 94 | | pF |
| | Reverse Recovery Time | $I_F=1A, V_R=30V$ di/dt =200A/\(\mu\)s | $T_j = 25$ °C | | 21 | | ns |
| t_{rr} | Reverse Recovery Time | $ T_{i} = 25^{\circ}C $ $ T_{j} = 125^{\circ}C $ $ T_{j} = 25^{\circ}C $ $ T_{j} = 25^{\circ}C $ | $T_i = 25^{\circ}C$ | | 24 | | |
| | | | | 48 | | | |
| I_{RRM} | Maximum Reverse Recovery Current | | | 3 | | Α | |
| 1RRM | Widamidin Reverse Recovery Current | $V_R = 133V$ | $T_{i} = 125^{\circ}C$ | | 6 | | Λ |
| 0 | Daviana Dagayany Changa | $di/dt = 200A/\mu s$ | $T_j = 25$ °C | | 33 | | nC |
| Q_{rr} | Reverse Recovery Charge | | $T_j = 125$ °C | | 150 | | IIC |
| t_{rr} | Reverse Recovery Time | $I_F = 30A$ $V_R = 133V$ $di/dt = 1000A/\mu s$ | | | 31 | | ns |
| Q_{rr} | Reverse Recovery Charge | | $T_j = 125$ °C | | 335 | | nC |
| I_{RRM} | Maximum Reverse Recovery Current | | | | 19 | | A |



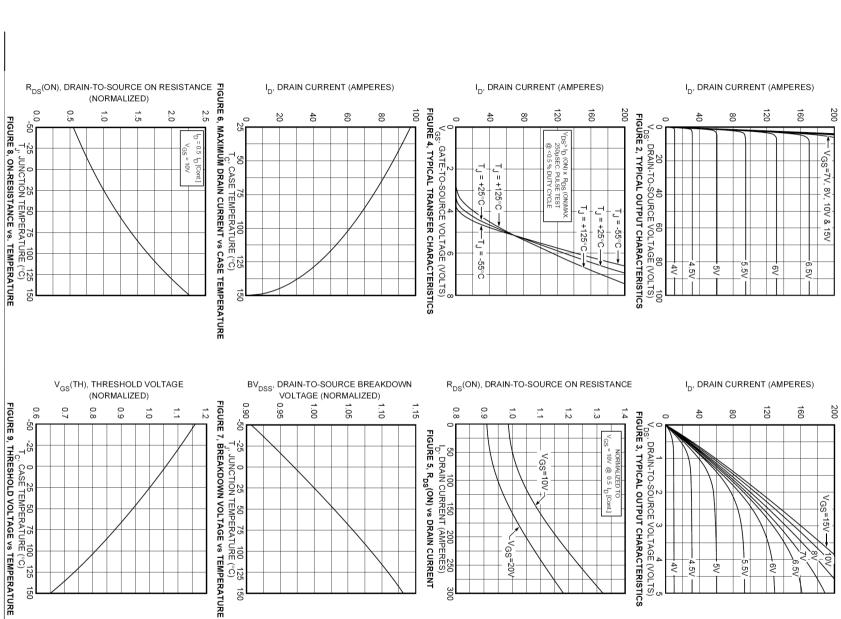
Thermal and package characteristics

| Symbol | Characteristic | | Min | Тур | Max | Unit |
|------------------|--|------------------------|------|------|------|------|
| R_{thJC} | Junction to Case Thermal Resistance | MOSFET | | | 0.28 | °C/W |
| | | Diode | | | 1.21 | |
| R_{thJA} | Junction to Ambient (IGBT & Diode) | | | | 20 | |
| V_{ISOL} | RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz | | 2500 | | | V |
| T_{J}, T_{STG} | Storage Temperature Range | | -55 | | 150 | °C |
| $T_{ m L}$ | Max Lead Temp for Soldering:0.063" from case for 10 sec | om case for 10 sec 300 | | | | |
| Torque | Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine) | | | | 1.5 | N.m |
| Wt | Package Weight | | | 29.2 | | g |

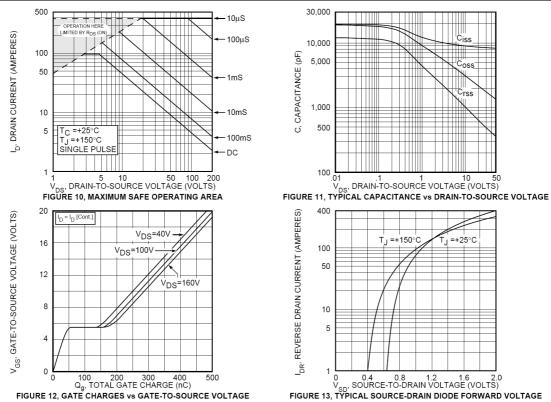
Typical MOSFET Performance Curve



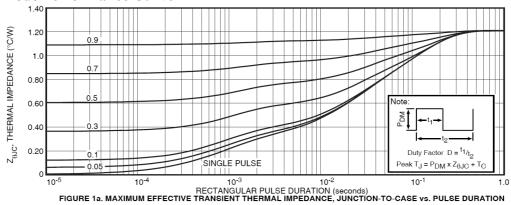








Typical Diode Performance Curve



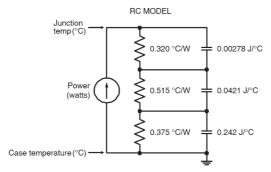
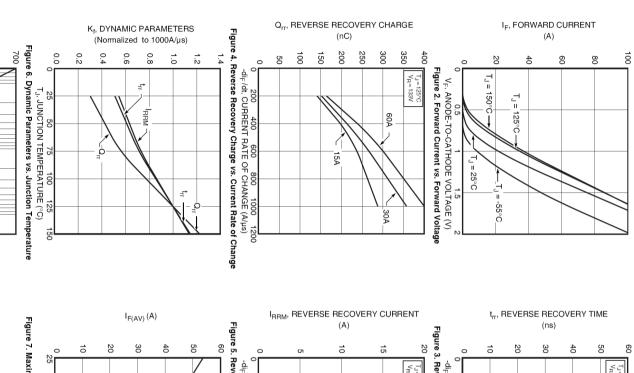
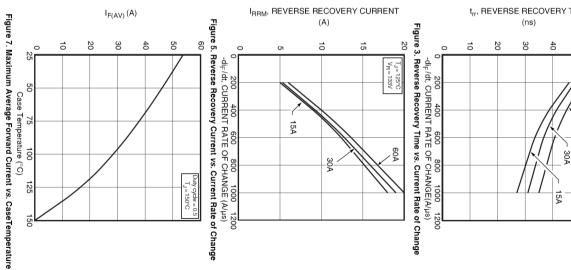


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL







C., JUNCTION CAPACITANCE

(pF)

300

200

100

0

.6 1 10 200 V_R, REVERSE VOLTAGE (V) Figure 8. Junction Capacitance vs. Reverse Voltage



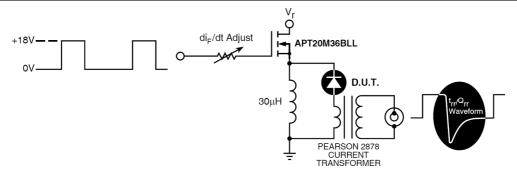
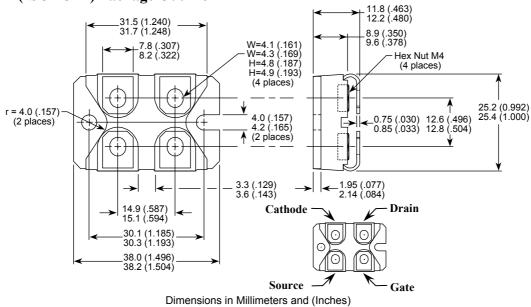


Figure 9. Diode Test Circuit

- 1 I_F Forward Conduction Current
 2 di_F/dt Rate of Diode Current Change Through Zero Crossing.
 3 I_{RRM} Maximum Reverse Recovery Current.
 4 t_{rr} Reverse Recovery Time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I_{RRM} and 0.25•I_{RRM} passes through zero.
- 6 Q_{rr} Area Under the Curve Defined by I_{RRM} and t_{rr}.

Figure 10, Diode Reverse Recovery Waveform and Definitions

SOT-227 (ISOTOP®) Package Outline





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